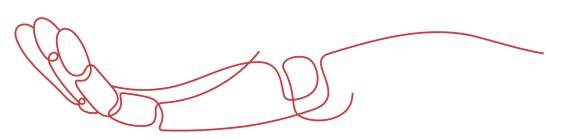




PRODUCT DATA SHEET



To learn more about JGSEMI, please visit our website at







Datasheet

ources Samples

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

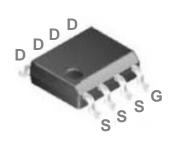
These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

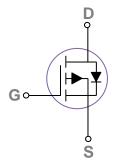
BVDSS	RDSON	ID
-30V	7.2m Ω	-16A

Features

- -30V, -16A, $RDS(ON) = 7.2m\Omega@VGS = -10V$
- Fast switching
- Green Device Available
- Suit for -4.5V Gate Drive Applications

SOP8 Pin Configuration





Applications

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Application

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-30	V
V _G s	Gate-Source Voltage	±20	V
1_	Drain Current – Continuous (T _A =25°C)	-16	А
lD	Drain Current – Continuous (T _A =70°C)	-12.8	А
I _{DM}	Drain Current – Pulsed1	-64	А
EAS	Single Pulse Avalanche Energy ²	125	mJ
IAS	Single Pulse Avalanche Current ²	-50	А
D-	Power Dissipation (T _A =25°C)	3.1	W
P _D	Power Dissipation – Derate above 25°C	0.025	W/°C
Т _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA}	Thermal Resistance Junction to Ambient		40	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D = - 250uA	-30			V
I _{DSS} Drain-Source Leakage Current	Drain Source Leekage Current	V _{DS} = - 30V , V _{GS} =0V , T _J =25°C			-1	uA
	V _{DS} = - 24V , V _{GS} =0V , T _J =125°C			-10	uA	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA

On Characteristics

R _{DS(ON)} Static Drain-Source On-Resistance	Static Drain-Source On-Resistance	V _{GS} =-10V , I _D =-6A		6	7.2	mΩ
	Static Dialif-Source Off-Resistance	V _{GS} = - 4.5V , I _D = - 4A		8.6	12	mΩ
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=-250uA$	- 1.0	- 1.6	- 2.5	V
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-1A		7		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{3, 4}			65.8	100	
Q_{gs}	Gate-Source Charge ^{3, 4}	V_{DS} =-24V , V_{GS} =-10V , I_{D} =-8A		20	30	nC
Q_{gd}	Gate-Drain Charge ^{3, 4}			11	16	
T _{d(on)}	Turn-On Delay Time ^{3, 4}			35		
Tr	Rise Time ^{3, 4}	V_{DD} =-15V, V_{GS} =-10V , R_{G} =3.3 Ω		14		no
$T_{d(off)}$	Turn-Off Delay Time ^{3, 4}	I _D =-1A		235		ns
Tf	Fall Time ^{3, 4}			85		
Ciss	Input Capacitance			3875	5810	
Coss	Output Capacitance	V _{DS} =-24V , V _{GS} =0V , F=1MHz		505	560	pF
Crss	Reverse Transfer Capacitance			380	570	
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz		6.9		Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			-13	Α
I _{SM}	Pulsed Source Current ²	VG=VD=UV, Force Current			-26	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1	V
Trr	Reverse Recovery Time	VR=30V, IS=10A ,		235		ns
Qrr	Reverse Recovery Charge	di/dt=100A/µs , TJ=25℃		337		nC

Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =50A., R_{G} =25 Ω ,Starting T_{J} =25 $^{\circ}$ C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.



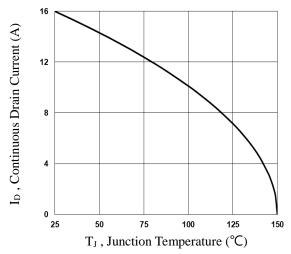


Fig.1 Continuous Drain Current vs. TJ

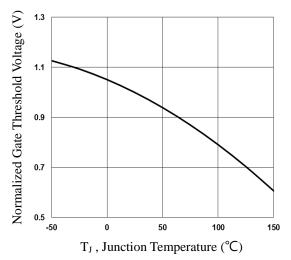


Fig.3 Normalized V_{th} vs. T_J

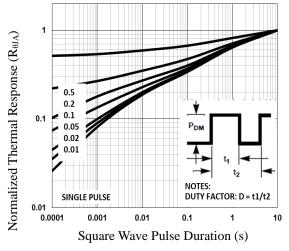


Fig.5 Normalized Transient Impedance

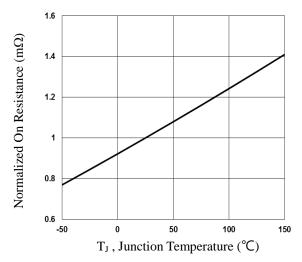


Fig.2 Normalized RDSON vs. T_J

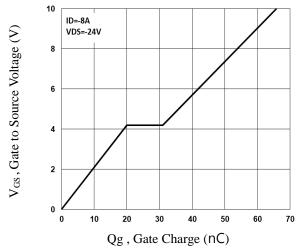


Fig.4 Gate Charge Waveform

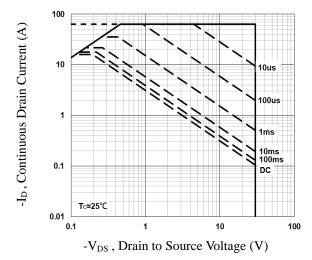
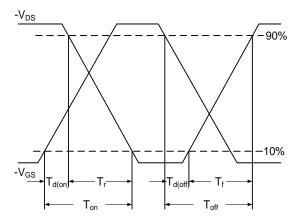


Fig.6 Maximum Safe Operation Area





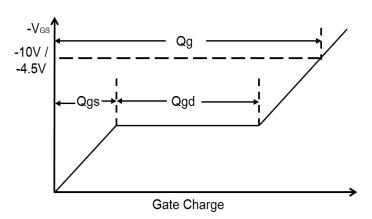
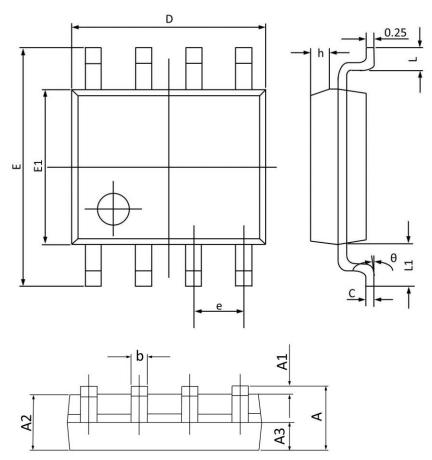


Fig.8 Gate Charge Waveform



SOP8 PACKAGE INFORMATION



Symbol	Dimensions 1	In Millimeters	Dimension	s In Inches
Symbol	Min	Max	Min	Max
A	1.350	1.750	0.053	0.068
A1	0.100	0.250	0.004	0.009
A2	1.300	1.500	0.052	0.059
A3	0.600	0.700	0.024	0.027
b	0.390	0.480	0.016	0.018
c	0.210	0.260	0.009	0.010
D	4.700	5.100	0.186	0.200
E	5.800	6.200	0.229	0.244
E 1	3.700	4.100	0.146	0.161
e	1.270(BSC)		0.050	(BSC)
h	0.250	0.500	0.010	0.019
L	0.500	0.800	0.019	0.031
L1	1.050	(BSC)	0.041(BSC)	
θ	0°	8°	0 °	8°



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